

DOCKET NO: 204612US2



IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF

YUUICHI HIRANO ET AL.

: EXAMINER: TRAN, THIEN F.

SERIAL NO: 09/802,886

:

2ND RCE FILED: HEREWITH

: GROUP ART UNIT: 2811

FOR: SEMICONDUCTOR DEVICE

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#25 E
Amendt de w/
RCE
4
1/8/04

AMENDMENT FILED CONCURRENTLY WITH REQUEST FOR CONTINUED

EXAMINATION (RCE)

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

Prior to a further examination on the merits, please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 5 of this paper.